## AMENDMENTS TO THE CLAIMS:

Please amend Claims 2, 8, 11, and 12 as follows:

1. (Original) A method of manufacturing an optical element, comprising the stages of:

machining a substrate;

removing a contamination from a surface of the substrate after the machining; and

removing a deterioration layer in the surface of the substrate after the machining.

- 2. (Currently Amended) A method according to claim 1, wherein the substrate is made of CaF2 CaF<sub>2</sub> single crystal.
- 3. (Original) A method according to claim 1, wherein the contamination removing stage includes the stage of focusing laser light on the surface of the substrate.
- 4. (Original) A method according to claim 3, wherein the laser light is KrF excimer laser light.
- 5. (Original) A method according to claim 1, wherein the deterioration layer removing stage includes a step of ultrasonic-washing the surface of the substrate with an aqueous wash solution.

- 6. (Original) A method according to claim 5, wherein in the ultrasonic washing step, ultrasonic washing with a wash solution containing a surface-active agent and ultrasonic washing with pure water are performed in succession.
- 7. (Original) A method according to claim 6, wherein the deterioration layer removing stage further includes a step of rinsing the substrate with pure water and a step of drying the rinsed substrate after the surface of the substrate is ultrasonic-washed with pure water.
- 8. (Currently Amended) A method according to claim 1, wherein the contamination removing stage includes the steps of:

immersing the substrate in acetone;

taking out the substrate from the acetone and then wiping the surface thereof with a paper containing diamond powder;

processing the wiped surface of the substrate with solvent; and processing the surface-processed substrate with UV/03 UV/03.

- 9. (Original) A method according to claim 8, wherein the solvent is ether.
- 10. (Original) A method according to claim 6, wherein the surface-active agent is an alkalescent surface-active agent.
- 11. (Currently Amended) A method according to claim 7, wherein the drying step is performed with [[a]] warm air.

- 12. (Currently Amended) A method according to claim 1, wherein the machining stage includes a step of cutting the substrate from a CaF2 CaF<sub>2</sub> single crystalline base substrate and polishing the surface of the cut substrate with a predetermined surface shape.
- 13. (Original) A method according to claim 12, wherein the machining stage includes a step of forming a protective film on the polished surface of the substrate, and the contamination removing stage is performed after the protective film is removed from the surface of the substrate.
- 14. (Original) A method according to claim 1, wherein the contamination is one of abrasive, oil content, and other foreign matter.
- 15. (Original) A method according to claim 1, wherein a surface roughness of the optical element is 0.5 to 0.55 nm by an examination with an RMS.
- 16. (Original) A method according to claim 1, wherein the optical element is one of a lens, a prism, a transparent plate, and a transparent rod.
- 17. (Original) A method of manufacturing an optical element, comprising the steps of:

machining a substrate; and

removing a deterioration layer in the surface of the substrate after the machining.

18. (Original) An exposure apparatus comprising:

an optical system having an optical element manufactured by the

manufacturing method according to any one of claims 1 to 17, for illuminating a wafer

with laser light having a wavelength of 200 nm or less.

- 19. (Original) A device manufacturing method comprising the stages of: exposing the wafer by the exposure apparatus according to claim 18; and developing the exposed wafer.
- 20. (Original) An optical element washing machine including an optical element holding unit, an excimer laser unit, and a focal control unit for focusing excimer laser light from the excimer laser unit, the optical element holding unit having a holder, a rotation stage, and a three dimensional control stage,

in which the holder is means for holding an optical element, the rotation stage is means for rotating the holder,

the three dimensional control stage is a constitution element of position control means for causing the rotation stage to move in a vertical direction and/or a horizontal direction,

the excimer laser unit is a light source for emitting ultraviolet radiation, and the focal control unit has basic control value setting means for setting a basic control value for a focal matching state of the ultraviolet radiation from the excimer laser unit, focal matching determination means for determining a focal matching state of the excimer laser light, and correction means for sending a correction amount corresponding to a determination result of the focal matching determination means to the position control means.